

Notice of References Cited	Application/Control No. 10/806,260	Applicant(s)/Patent Under Reexamination KIEL ET AL.	
	Examiner Yevgeny Valenrod	Art Unit 1621	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,383,471	05-2002	Chen et al.	424/45
*	B	US-2004/0192616	09-2004	Kiel et al.	514/023
*	C	US-2004/0192617	09-2004	Kiel et al.	514/023
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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